Superconductivity in diamond thin films well above liquid helium temperature

Yoshihiko Takano,^{a)} Masanori Nagao, Isao Sakaguchi, Minoru Tachiki, and Takeshi Hatano *National Institute for Materials Science*, 1-2-1 Sengen, Tsukuba 305-0047 Japan

Kensaku Kobayashi, Hitoshi Umezawa, and Hiroshi Kawarada School of Science and Engineering, Waseda University, 3-4-1 Okubo, Shinjuku, Tokyo 169-8555, Japan

(Received 7 June 2004; accepted 6 August 2004)

We report unambiguous evidence for superconductivity in a heavily boron-doped diamond thin film grown by microwave plasma-assisted chemical vapor deposition (MPCVD). An advantage of the MPCVD-deposited diamond is that it can contain boron at high concentration, especially in (111)-oriented films. Superconducting transition temperatures are determined by transport measurements to be 7.4 K for T_C onset and 4.2 K for zero resistance. The upper critical field is estimated to be 7 T. Magnetization as a function of magnetic fields shows typical type-II superconducting properties. © 2004 American Institute of Physics. [DOI: 10.1063/1.1802389]

Diamond has always been adored as a jewel. Even more fascinating about diamond are its outstanding physical properties; it is the hardest material ever known in the world, with the highest thermal conductivity of 22 W/cm K. Meanwhile, when we turn to its electrical properties, diamond is a rather featureless electrical insulator. However, with boron doping, it becomes a *p*-type semiconductor, with boron acting as a charge acceptor.^{1,2} It is a promising material for electrical applications,³ such as high-frequency and highpower devices,⁴ owing to its high breakdown field (>10 MV/cm) and high carrier mobility.

On the other hand, a heavily boron-doped diamond shows metallic conduction and it has been in use as electrodes in the field of electrochemistry.^{5,6} Its physical properties, however, have remained largely unexplored, particularly at low temperatures. Therefore, the recent news of superconductivity in heavily boron-doped diamond synthesized by high-pressure sintering was received with considerable surprise.⁷ Opening up new possibilities for diamond-based electrical devices, a systematic investigation of these phenomena clearly needs to be achieved.

Application of diamond to actual devices requires it to be made into the form of wafers or thin films. The only procedures at present available to this end are low-pressure synthesis methods such as the chemical vapor deposition (CVD).^{8,9} In this letter, we present unambiguous evidence of superconductivity in a diamond thin film deposited by a CVD method. The onset of superconducting transition is found to be 7.4 K, which is higher than the reported value in Ref. 7 and well above liquid helium temperature. This finding, as discussed here, establishes the superconductivity to be a universal property of boron-doped diamond, demonstrating that device application is indeed a feasible challenge.

A principle advantage of diamond thin films deposited by the CVD method is that it can contain boron at relatively higher concentrations compared to the bulk diamonds synthesized at high pressure. Especially in (111)-oriented thin film, boron can be doped at a rate of about one order higher than in (001)-oriented samples.¹⁰ To achieve superconductivity, it is apparently crucial to realize a carrier concentration sufficiently high to induce an insulator-to-metal transition. We are thus lead to expect the (111)-oriented thin film to be a strong candidate for a superconductor with transition temperature above liquid helium temperature or higher.

The heavily boron-doped polycrystalline diamond thin film was deposited on a silicon (001) substrate using the microwave plasma-assisted chemical vapor deposition (MPCVD) method.⁹ The silicon substrates were pretreated by ultrasonic wave using diamond powder. Deposition was carried out under the condition of 50 Torr chamber pressure, 500 W microwave power and 800–900 °C substrate temperature using a dilute gas mixture of methane and trimethylboron in hydrogen. Methane concentration was 1% in hydrogen with a *B/C* ratio of 2500 ppm. After a 9 hr deposition, a film of 3.5 µm thickness was obtained.

A scanning electron microscopy (SEM) image of the film is shown in Fig. 1. The film morphology consists predominantly of {111} facets with a mean grain size of 1 µm. The x-ray diffraction pattern was obtained with Cu K_{α} radiation (wavelength=0.154 nm). A sharp peak was detected at 2 θ =43.9° corresponding to the (111) refraction of cubic cell of diamond structure. Scarce detections of (220), (311), and (400) peaks suggest the {111}-textured growth of the film.

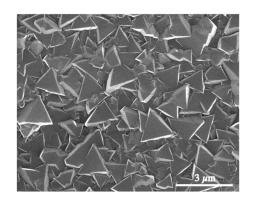


FIG. 1. SEM image of the film deposited by MPCVD method. The film morphology consists predominantly of {111} facets.

2851

Downloaded 17 Oct 2004 to 144.213.253.14. Redistribution subject to AIP license or copyright, see http://apl.aip.org/apl/copyright.jsp

^{a)}Author to whom correspondence should be addressed; electronic mail: TAKANO.Yoshihiko@nims.go.jp

^{© 2004} American Institute of Physics

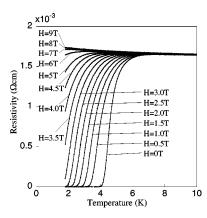


FIG. 2. Temperature dependence of resistivity under several values of magnetic fields. In the absence of the field, the resistivity began to drop at around 7 K, which corresponds to T_C onset, and dropped to zero at around 4.2 K (T_C offset).

The transport properties were measured between room temperature and 1.7 K. Figure 2 shows the temperature dependence of resistivity of the film under several values of magnetic fields up to 9 T. With decreasing temperature, the resistivity initially decreases slightly but increases gradually below 200 K. The resistivity began to drop at around 7.4 K. which corresponds to the onset of a superconducting transition, and dropped to zero at around 4.2 K (T_C offset) in the absence of the field. The superconducting transition temperature is shifted with the increasing of the applied field. The field dependence of the onsets and offsets of T_C is plotted in Fig. 3. The extrapolation of T_C onset approaches the value of 10.4 T. Assuming the dirty limit, the upper critical field H_{C2} is estimated to be 7 T. This value is roughly similar to the $H_{C2}^{1/c}$ of the *c*-axis direction in MgB₂.^{11,12} The irreversibility field is found to be 5.12 T at 0 K. We have also confirmed reproducibility of superconductivity in different samples, the systematics of which shall be reported elsewhere.

The magnetization properties were measured by a superconducting quantum interference device magnetometer down to 1.78 K. The temperature dependence of the magnetization is plotted in Fig 4. Diamagnetic signals corresponding to superconductivity appeared below 4 K, where the resistance drops to zero. The large difference between the zerofield-cooling (ZFC) and field-cooling (FC) curvatures indicates that the material has a fairly large flux pinning

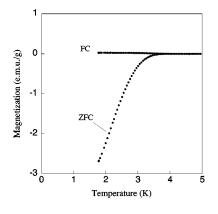
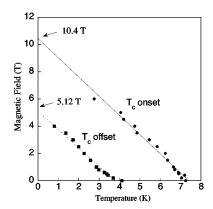


FIG. 4. Temperature dependence of the magnetization at magnetic field of 1 Oe measured under the ZFC and FC conditions.

force, resulting in the trapping of magnetic flux in the FC condition.

Magnetization versus magnetic field (M-H) curvature obtained at 1.8 K was plotted in Fig. 5. Large symmetric hysteresis curvature shows the characteristics of typical type-II superconductors. From the hysteresis of the magnetization curve ΔM (emu/cm³), we can estimate critical current density J_C on the assumption of a critical-state model with the simple formula $J_C=30 \Delta M/d$, where *d* is the size of the sample.¹³ The J_C at 0 T is estimated to be 200 A/cm².

Having established firmly the uniformity of superconductivity in these materials, we finally turn briefly to physical implications. Theoretical proposals of Refs. 14 and 15 have very recently been put forth that make the case that boron-doped diamond may be viewed as a three-dimensional analog of MgB₂, and can be understood qualitatively in terms of a phonon mechanism incorporating the McMillan relation. Based on Hall conductivity measurements, we estimate the carrier concentration of our sample to be 9.4 $\times 10^{20}$ /cm³, which corresponds to a boron-doping rate of 0.53%. In fact, we have confirmed superconductivity in samples with doping rates as low as 0.18%. These values are considerably lower than those reported for materials sintered at high pressure, as well as theoretical estimates based on a first-principles evaluation incorporating phonon dynamics. These discrepancies may suggest (a) higher efficiency of doping in our samples, and (b) a stronger electron-phonon coupling than previously anticipated. A moderate Coulomb repulsion and disorder may be another factor that needs to be considered in future theoretical treatments.¹⁶



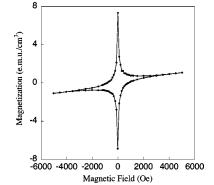


FIG. 3. The field dependence of the onsets and offsets of T_C . The H_{C2} and irreversibility field are estimated to be 7 and 5.12 T, respectively.

FIG. 5. M-H curvature obtained at 1.8 K.

Downloaded 17 Oct 2004 to 144.213.253.14. Redistribution subject to AIP license or copyright, see http://apl.aip.org/apl/copyright.jsp

- ¹A. T. Collins and W. S. Williams, J. Phys. C 4, 1789 (1970).
- ²R. M. Cherenko, Phys. Rev. B **7**, 4560 (1973).
- ³J. E. Butler and R. L. Woodin, Philos. Trans. R. Soc. London, Ser. A **342**, 209 (1993).
- ⁴H. Umezawa, H. Taniuchi, H. Ishizaka, T. Arima, N. Fujihara, M. Tachiki, and H. Kawarada, IEEE Electron Device Lett. **EDL-23** 121 (2002).
- ⁵Y. Pleskov, A. Sakharvoa, M. Krotova, M. L. L. Bouilov, and B. V. Spitsyn, J. Electroanal. Chem. Interfacial Electrochem. **228**, 19 (1987).
- ⁶G. Swain and R. Ramesham, Anal. Chem. **65**, 3958 (1993).
- ⁷E. A. Ekimov, V. A. Sidorov, E. D. Bauer, N. N. Mel'nik, N. J. Curro, J.
- D. Thompson, and S. M. Stishov, Nature (London) **428**, 542 (2004).
- ⁸B. V. Spitsyn, L. L. Builov, and B. V. Deryagin, J. Cryst. Growth **52**, 219 (1981).

- ⁹M. Kamo, Y. Sato, S. Matsumoto, and N. Setaka, J. Cryst. Growth **62**, 642 (1983).
- ¹⁰K. Ushizawa, K. Watanabe, T. Ando, I. Sakaguchi, M. Nishitani-Gamo, Y. Sato, and H. Kanda, Diamond Relat. Mater. **7** 1719 (1998).
- ¹¹M. Xu, H. Kitazawa, Y. Takano, J. Ye, K. Nishida, H. Abe, A. Matsushita, N. Tsujii, and G. Kido, Appl. Phys. Lett. **79**, 2779 (2001).
- ¹²Y. Takano, H. Takeya, H. Fujii, H. Kumakura, T. Hatano, and K. Togano, Appl. Phys. Lett. **78**, 2914 (2001).
- ¹³C. P. Bean, Phys. Rev. Lett. **8**, 250 (1962).
- ¹⁴L. Boeri, J. Kortus, and O. K. Andersen, cond-mat/0404447.
- ¹⁵K.-W. Lee and W. E. Pickett, cond-mat/0404547.
- ¹⁶G. Baskaran, cond-mat/0404286.